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## SwissFEL Aramis beamline photon diagnostics. Erratum

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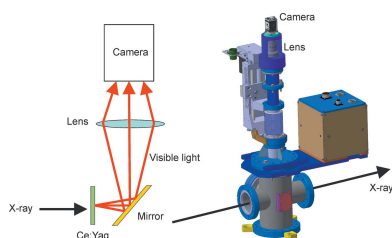
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The list of authors in the paper by Juranić *et al.* (2018) [*J. Synchrotron Rad.* **25**, 1238–1248] is corrected.

Two authors, Ariana Cassar and Marco Calvi, were omitted in the published version of the paper by Juranić *et al.* (2018). The correct author list is given above.

### References

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